Power MOSFET

30 V, 41 A, Single N-Channel, µ8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management
- Motor Control

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	30	V		
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	I _D	12.7	А
Current $R_{\theta JA}$ (Note 1)		T _A = 85°C		9.2	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	P _D	2.17	W
Continuous Drain		T _A = 25°C	۱ _D	18	А
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 85°C		13	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	$T_A = 25^{\circ}C$	PD	4.35	W
Continuous Drain	State	T _A = 25°C	I _D	8.0	А
Current $R_{\theta JA}$ (Note 2)		T _A = 85°C		5.7	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	P _D	0.84	W
Continuous Drain		$T_{\rm C} = 25^{\circ}{\rm C}$	I _D	41	А
Current $R_{\theta JC}$ (Note 1)		T _C = 85°C	1	29	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	22.3	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	125	А
Operating Junction and S	itorage Ten	nperature	Т _Ј , T _{stg}	–55 to +150	°C
Source Current (Body Die	۱ _S	25	А		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
$ \begin{array}{l} \mbox{Single Pulse Drain-to-So} \\ \mbox{(T_J = 25^{\circ}C, V_{DD} = 50 V, V)} \\ \mbox{I_L = 25 } \\ \mbox{A}_{pk}, \mbox{L = 0.1 mH, F} \end{array} $	E _{AS}	31	mJ		
Lead Temperature for So (1/8" from case for 10 s)	dering Pur	poses	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability. 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

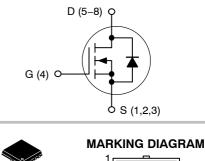


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX
30 V	7.2 mΩ @ 10 V	41 A
	11 mΩ @ 4.5 V	

N-Channel MOSFET



WDFN8 (µ8FL) CASE 511AB

4943 А

Y WW

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- Specific	Device Code	-
= Assembl		

(Note: Microdot may be in either location)

= Work Week = Pb-Free Package

= Year

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4943NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4943NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	5.6	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	57.5	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	149.2	
Junction-to-Ambient – (t \leq 10 s) (Note 3)	R _{0JA}	28.7	

3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

		•					-
Parameter	Symbol	Test Condit	ion	Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D =	250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$ $T_{J} = 25^{\circ}C$				1.0	μΑ
		$V_{DS} = 24 V$	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$				±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	250 μΑ	1.2		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	N/ 40.1/	I _D = 20 A		5.1	7.2	mΩ
	V _{GS} = 10 V	l _D = 10 A		5.1	1		
			I _D = 20 A		7.6	11	1
		V _{GS} = 4.5 V	l _D = 10 A		7.5		1
Forward Transconductance	9 FS	V _{DS} = 1.5 V, I _D	= 15 A		29.3		S

CHARGES AND CAPACITANCES

Input Capacitance	C _{iss}		1386	pF
Output Capacitance	C _{oss}	V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 15 V	440	
Reverse Transfer Capacitance	C _{rss}		23	
Total Gate Charge	Q _{G(TOT)}		9.2	nC
Threshold Gate Charge	Q _{G(TH)}		2.3	
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 20 A	4.5	
Gate-to-Drain Charge	Q _{GD}		1.35	
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 20 A	20.4	nC
SWITCHING CHARACTERISTICS	(Note 6)	•		

5. Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.

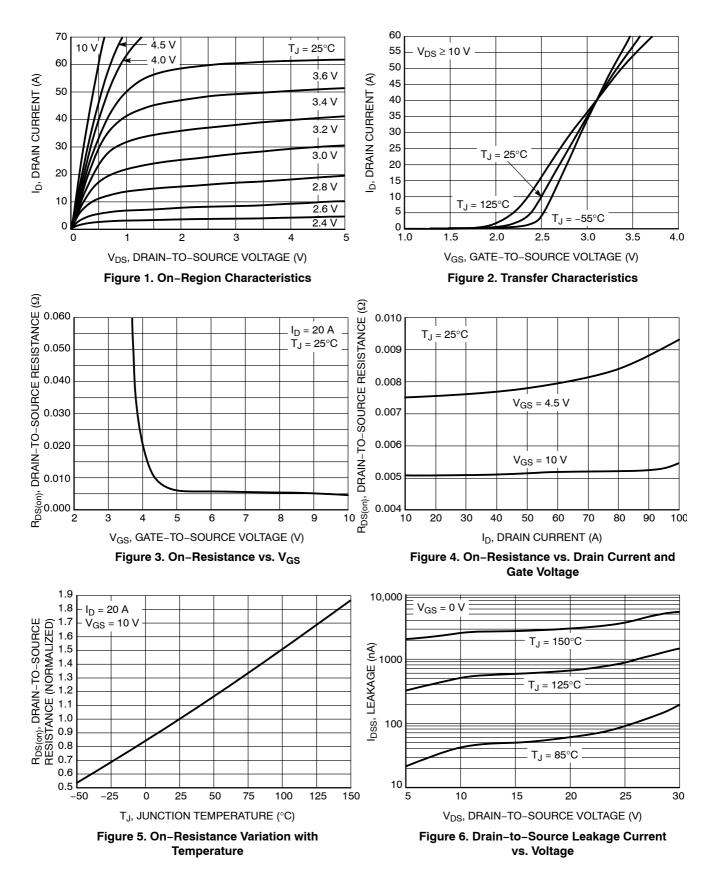
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

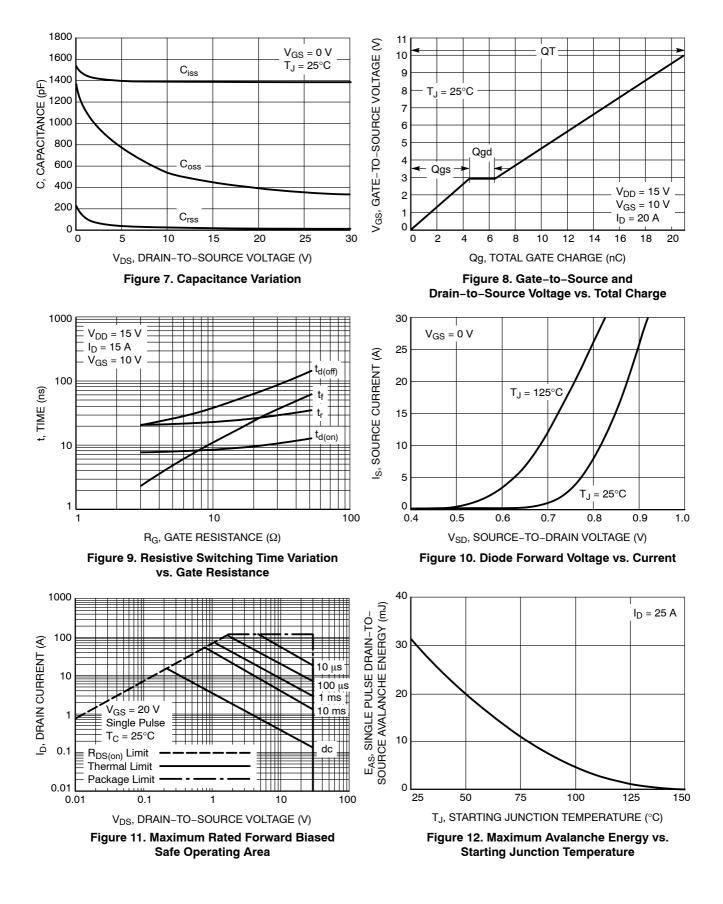
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	S (Note 6)				•	-	-
Turn-On Delay Time	t _{d(on)}				7.6		ns
Rise Time	tr	V _{GS} = 10 V, V _{DS} =	= 15 V,		19.5		
Turn-Off Delay Time	t _{d(off)}	$I_{\rm D} = 15 \rm A, R_{\rm G} =$	3.0 Ω		22		
Fall Time	t _f				2.6		
DRAIN-SOURCE DIODE CHARA	ACTERISTICS						
Forward Diode Voltage	V _{SD}	$V_{SD} \qquad V_{GS} = 0 V, \\ I_{S} = 20 A \qquad T_{J} = 25^{\circ}C \\ T_{J} = 125^{\circ}C$		0.88	1.2	V	
			T _J = 125°C		0.78		
Reverse Recovery Time	t _{RR}	•			26.2		ns
Charge Time	ta	$V_{GS} = 0 V_{t} d_{1S}/d_{t} = 1$	100 A/μs,		13.2		
Discharge Time	t _b	$V_{GS} = 0 V, d_{IS}/d_t = 1$ $I_S = 20 A$			13		
Reverse Recovery Charge	Q _{RR}		ľ		17		nC
PACKAGE PARASITIC VALUES	-						
Source Inductance	L _S	T _A = 25°C			0.38		nH
Drain Inductance	L _D				0.054		1
Gate Inductance	L _G				1.3		1
Gate Resistance	R _G				1.1	2.0	Ω

 $\begin{array}{ll} \text{5. Pulse Test: pulse width = 300 } \mu\text{s, duty cycle } \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

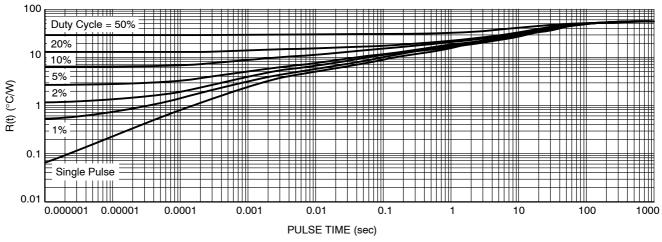
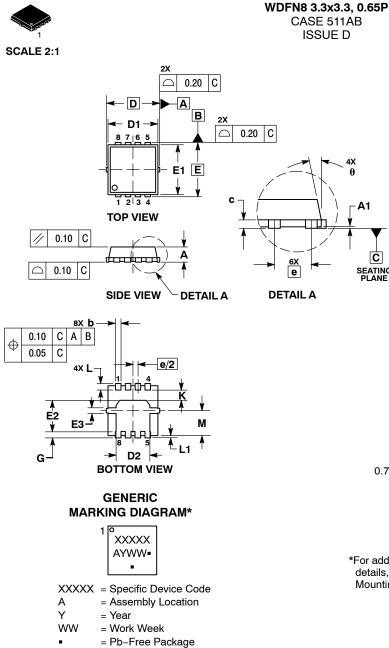


Figure 13. Thermal Response

DURSEM

DATE 23 APR 2012



*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

NOTES:

A1

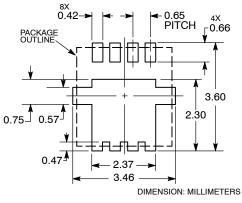
C

SEATING PLANE

- LES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 1. 2.
- 3.

	MI	LLIMETE	RS		INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	;	3.30 BSC		0	.130 BSC)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
Е	:	3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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